				7						
Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRAC	OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO.		SERIAL NO.				
IPE				240060US3	10/617,045					
1107.05		RENCES CITED BY AP		APPLICANT						
LISTUR	KEFE	- 1	<b>9</b> 1	Ryoji HABUCHI, et al.						
		CEP 1	(بير 2005 م	FILING DATE		GROUP				
SEP 16 2005				July 11, 2003	3681					
		DOCUMENT FRAM	PARK	U.S. PATENT DOCUMENTS						
EXAMINER		DOCOMENT	DOCUMENT   DATE   MAKE				FILING DATE			
INITIAL		NUMBER	ļ <u>.</u>		CLASS	CLASS IF APPROPRIATE				
mp	AA	4,630,504	12-23-86	Smirl						
	AB									
	AC									
	AD									
•	AE									
	AF									
	AG									
	AH			1	1					
	Al									
	AJ		<del>                                     </del>		1					
	AK				<del>                                     </del>		-			
	AL	· · · · · · · · · · · · · · · · · · ·	<del></del>	<u> </u>	<del>                                     </del>					
	AM		<del> </del>		1					
	AN		<del> </del>		<del> </del>	<del> </del>				
	73, ,			POSICAL DATENT DOCUMENTS	1	L1				
		т	<del></del>	PREIGN PATENT DOCUMENTS	•	·				
		DOCUMENT NUMBER	DATE	COUNTRY		YES	TRANSLATION NO			
20	AO	JP 2-173462	7-4-90	Japan (w/English Abstract)			x			
	ΑP	JP 7-113400	12-6-95	Japan (corresponding to U.S. 4,630,50	Japan (corresponding to U.S. 4,630,504)		×			
	AQ									
	AR									
	AS									
	AT		1							
	AU									
	AV									
		OTHER RE	EFERENCES (	(Including Author, Title, Date, Pertinen	t Pages, et	tc.)				
	AW									
	AX									
	AY		<u>~</u>							
	AZ	1/1			Addi	tional Refe	erences sheet(s) attached			
Evaminae		ROG	ERPANG			inneidorad / A / A				
Examiner In	PRIMARY EXAMINED									
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										

SHEET 1 OF 1

		18										
Farm PTO 1449	_	U. SPARTMENT	OFICHMERCE	ATTY DOCKET NO.		SERIAL NO.						
(Modified) PATE TRIANGERICE			240060US3	10/617,045								
				APPLICANT								
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Ryoji HABUCHI, et al.								
				FILING DATE	GROUP							
				July 11, 2003	3681							
U.S. PATENT DOCUMENTS												
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB		LING DATE				
INITIAL		NUMBER	DATE	NAME	CLASS	CLASS	IF A	PPROPRIATE				
	AA											
	AB											
•	AC		<u> </u>									
	AD											
	AE											
	AF											
	AG											
	AH											
	Al											
-	AJ		1			1						
	AK				1	<u> </u>						
	AL		1		1			****				
	AM											
	AN		1		1							
		<u> </u>	FC	REIGN PATENT DOCUMENTS		J	<u> </u>					
	<del></del>			T		T						
		DOCUMENT NUMBER	DATE	COUNTRY		YES		LATION NO				
M	AO	GB 2144814 A	03/13/1985	United Kingdom								
U	AP											
	AQ											
	AR											
	AS											
	AT											
	AU											
	ΑV											
		OTHER R	EFERENCES	(Including Author, Title, Date, Pertine	nt Pages, e	itc.)						
	AW		- <del></del>									
	AVV											
	AX		·									
	AY	A	200									
	AZ			litional References sheet(s) attached								
Examiner		PRIMARY	R PANG EXAMINER	· ·	Date Considered / 12 - 12							
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.												
conformance and not considered. Include copy of this form with next communication to applicant.												